Sea	rch	Notes	;

Application/Control No.	Applicant(s)/Patent under Reexamination
10/032,097	LEE ET AL.
Examiner	Art Unit
 Neeraj Bhatia	2661

SEARCHED			
Class	Subclass	Date	Examiner
370	395,378, 379,412	9/16/2005	NB
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
370/395,378,379,412 (text search only- see search history printout)	9/16/2005	NB		
EAST: US-PG PUB;USPAT;USOCR (text search only - see search history printout)	9/16/2005	NB		
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